TEXAS INSTRUMENTS

TPD1S514

SLVSCF6B –APRIL 2014–REVISED SEPTEMBER 2014

TPD1S514 USB Charger Over Voltage, Surge and ESD Protection for V_{BUS} PIN

1 Features

- Over Voltage Protection at V_{BUS_CON} up to 30-V DC
- Precision OVP (< ± 1% Tolerance)
  - Factory programmable V_{OVP} of 5.6 V to 15 V
- Low R_{ON} nFET Switch Supports Host and Charging Mode
- Dedicated V_{BUS_POWER} pin offers flexible power up options under dead battery condition
- Transient Protection for V_{BUS} Line:
  - IEC 61000-4-2 Contact Discharge ±15 kV
  - IEC 61000-4-2 Air Gap Discharge ±15 kV
  - IEC 61000-4-5 Open Circuit Voltage 100 V
    - Precision Clamp circuit limits the V_{BUS_SYS} Voltage < V_{OVP}
- Factory Programmable Startup and Soft Start delays
- USB Inrush Current Compliant
- Thermal Shutdown (TSD) Feature

2 Applications

- Cell Phones
- Tablets
- eBook
- Portable Media Players
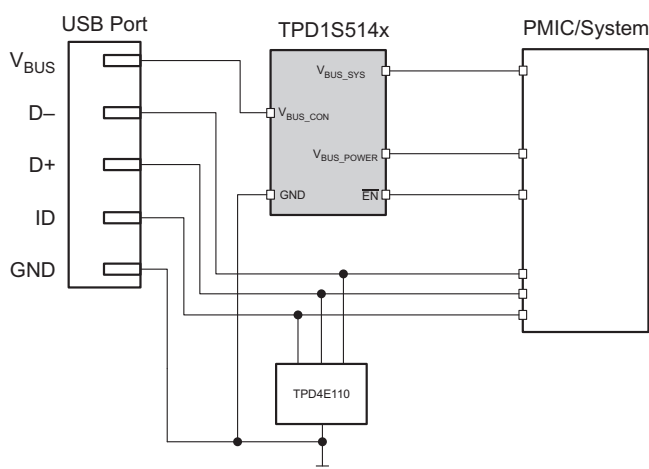- 5-V, 9-V, and 12-V Power Rails

3 Description

The TPD1S514 is a single-chip protection solution for the USB V_{BUS} line or other power buses. The bidirectional nFET switch ensures safe current flow in both charging and host mode while protecting the internal system circuits from any over voltage condition at the V_{BUS_CON} pin. On the V_{BUS_CON} pin, this device can handle over voltage protection up to 30-V DC. After the $\overline{EN}$ pin toggles low, the TPD1S514 waits 20 ms before turning ON the nFET through a soft start delay. TPD1S514 can be factory programmed to multiple V_{OVP}, start up and soft start delay combinations. See the *Device Comparison* table.

Device Information[1]

DEVICE NAME	PACKAGE	BODY SIZE (NOM)
TPD1S514	WCSP (12)	1.29 mm × 1.99 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

TPD1S514 Circuit Protection Scheme
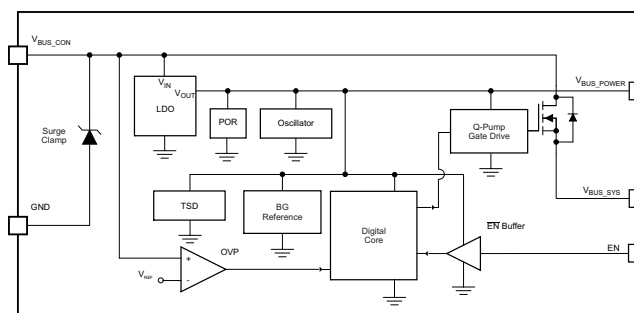

TPD1S514 Block Diagram

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4 Revision History

Changes from Revision A (July 2014) to Revision B   **Page**

- Changed Body size to fix rounding error. 1

Changes from Original (April 2014) to Revision A   **Page**

- Removed Preview status of TPD1S514-2. 1
- Updated Device Comparison table. 3
- Updated Electrical Characteristics OVP Circuit table. 7

5 Device Comparison Table

TPD1S514 Family	V_{OVP} (V)			V_{OVP_HYS} (mV)	V_{BUS_POWER} (V)[1]		T_Startup delay (ms) options	T_Soft Start (ms) options
	Min	Typ	Max	Typ	Min	Typ	Typ	Typ
TPD1S514-1	5.9	5.95	5.99	100	4.7	4.95	20	3.5
TPD1S514-2	9.9	9.98	10.05	100	4.7	4.95		
TPD1S514-3 (Preview)	13.2	13.32	13.4	100	4.7	4.95		
TPD1S514-4	5.9	5.95	5.99	20	6.2	6.48		
TPD1S514-x	5.6 V – 15 V[1]			100	4.7	4.95	5, 20, 30, or 150[1][2]	0.1, 3.5, 4.9, or 6.7[1][2]

(1) With V_{BUS_CON} > 6.5V. See Sections *V_{BUS_POWER}, TPD1S514-1, TPD1S514-2, TPD1S514-3* and *V_{BUS_POWER}, TPD1S514* for full description.
(2) These parameters are factory programmable. See the *Manufacturer Programmable Internal Startup, SoftStart Delays, and OVP* section and contact your local sales representative.

6 Pin Configuration and Functions

TPD1S514 WCSP (YZ) PIN MAPPING
(TOP SIDE/SEE-THROUGH VIEW)
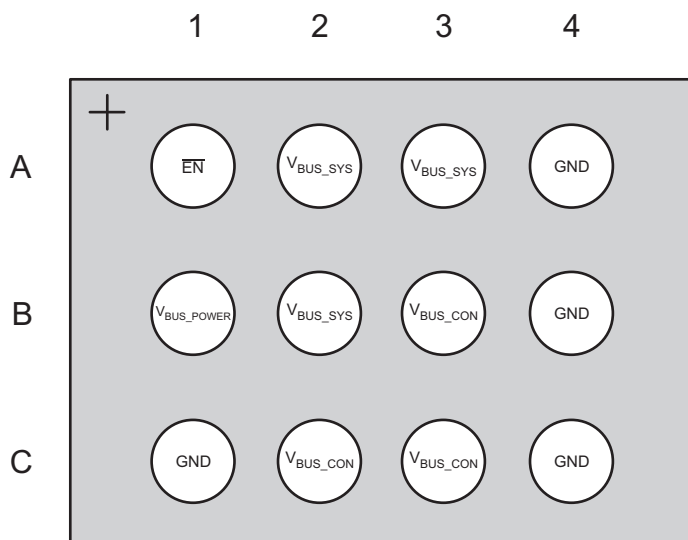
Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
$\overline{EN}$	A1	I	Enable Active-Low Input. Drive $\overline{EN}$ low to enable the switch. Drive $\overline{EN}$ high to disable the switch.
V_{BUS_POWER}	B1	O	5 V Power source controlled by V_{BUS_CON}.
V_{BUS_SYS}	A2, A3, B2	IO	Connect to internal VBUS plane.
V_{BUS_CON}	B3, C2, C3	IO	Connect to USB connector VBUS pin; IEC61000-4-2 ESD protection IEC61000-4-5 Surge protection.
GND	A4, B4, C1, C4	G	Connect to PCB ground plane.

7 Specifications

7.1 Absolute Maximum Ratings[1][2]

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{BUS_CON}	Supply voltage from USB connector		−0.3	30	V
V_{BUS_SYS}	Internal Supply DC voltage Rail on the PCB		−0.3	20	V
I_{BUS}	Continuous input current on V_{BUS_CON} pin[3]			3.5	A
I_{OUT}	Continuous output current on V_{BUS_CON} pin[3]			3.5	A
I_{PEAK}	Peak Input and Output Current on V_{BUS_CON}, V_{BUS_SYS} pin (10 ms)			8	A
I_{DIODE}	Continuous forward current through the FET body diode			1	A
I_{POWER}	Continuous Current through V_{BUS_POWER}			1	mA
V_{EN}	Voltage on Input pin ($\overline{EN}$)			7	V
V_{BUS_POWER}	Continuous Voltage at V_{BUS_POWER}	TPD1S514-1		See[4]	V
		TPD1S514-2		See[4]	
		TPD1S514-3 (Preview)		See[4]	
		TPD1S514-4		See[4]	
T_{STG}	Storage temperature range		−65	150	°C
T_A	Operating Free Air Temperature		−40	85	°C
	IEC 61000-4-5 Peak Pulse Current (t_p = 8/20µs)	V_{BUS_CON} pin		30	A
	IEC 61000-4-5 Peak Pulse Power (t_p = 8/20µs)	V_{BUS_CON} pin		900	W
	IEC 61000-4-5 Open circuit voltage (t_p = 1.2/50 µs)	V_{BUS_CON} pin		100	V
C_{LOAD}	Output load capacitance	V_{BUS_SYS} pin	0.1	100	µF
C_{CON}	Input capacitance	V_{BUS_CON} pin	0.1	50	µF
C_{POW}	V_{BUS_POWER} Capacitance	V_{BUS_POWER} pin	0.1	4.7	µF

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.
(2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
(3) Thermal limits and power dissipation limits must be observed.
(4) 6.9 V or V_{BUS_CON} + 0.3 V, whichever is smaller.

7.2 Handling Ratings

			MIN	MAX	UNIT
T_{stg}	Storage temperature range				°C
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins[1]	−2000	+2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins[2]	−500	500	V
		IEC 61000-4-2 Contact Discharge V_{BUS_CON} pin	−15	+15	kV
		IEC 61000-4-2 Air-gap Discharge V_{BUS_CON} pin	−15	+15	kV

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as 2000 V may actually have higher performance.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as 500 V may actually have higher performance.

Product Folder Links: *TPD1S514*

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	TYP	MAX	UNIT
V_{BUS_CON}	Supply voltage from USB connector	TPD1S514-1	3.5	5	5.9	V
		TPD1S514-2	3.5	9	9.9	
		TPD1S514-3 (Preview)	3.5	12	13.2	
		TPD1S514-4	3.5	5	5.9	
V_{BUS_SYS}	Internal Supply DC voltage Rail on the PCB	TPD1S514-1	3.9	5	5.9	V
		TPD1S514-2	3.9	9	9.9	
		TPD1S514-3 (Preview)	3.9	12	13.2	
		TPD1S514-4	3.9	5	5.9	
C_{LOAD}	Output load capacitance	V_{BUS_SYS} pin		2.2		µF
C_{CON}	Input capacitance	V_{BUS_CON} pin		1		µF
C_{POWER}	Capacitance on V_{BUS_POWER}	V_{BUS_POWER} pin		1		µF
T_A	Operating free-air temperature		−40		85	°C

7.4 Thermal Information

THERMAL METRIC[1]		TPD1S514 YZ 12 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	89	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	0.6	
$R_{\theta JB}$	Junction-to-board thermal resistance	16.3	
ψ_{JT}	Junction-to-top characterization parameter	2.7	
ψ_{JB}	Junction-to-board characterization parameter	16.2	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	n/a	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.

7.5 Supply Current Consumption

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		DEVICE NAME	TYP	MAX	UNIT
I_{VBUS_SLEEP}	V_{BUS_CON} Operating Current Consumption	Measured at V_{BUS_CON} pin, $\overline{EN}$ = 5 V	V_{BUS_CON} = 5 V	TPD1S514-1	150	245	µA
			V_{BUS_CON} = 9 V	TPD1S514-2	176	281	
			V_{BUS_CON} = 12 V	TPD1S514-3 (Preview)	195	308	
			V_{BUS_CON} = 5 V	TPD1S514-4	150	245	
I_{VBUS}		Measured at V_{BUS_CON} pin, $\overline{EN}$ = 0 V and no load	V_{BUS_CON} = 5 V	TPD1S514-1	228	354	µA
			V_{BUS_CON} = 9 V	TPD1S514-2	250	413	
			V_{BUS_CON} = 12 V	TPD1S514-3 (Preview)	337	456	
			V_{BUS_CON} = 5 V	TPD1S514-4	228	354	
I_{VBUS_SYS}	V_{BUS_SYS} Operating Current Consumption	Measured at V_{BUS_SYS} pin, V_{BUS_CON} = Hi-Z, $\overline{EN}$ = 0 V	V_{BUS_SYS} = 5 V	TPD1S514-1	210	354	µA
			V_{BUS_SYS} = 9 V	TPD1S514-2	250	424	
			V_{BUS_SYS} = 12 V	TPD1S514-3 (Preview)	333	461	
			V_{BUS_SYS} = 5 V	TPD1S514-4	210	354	
I_{HOST_LEAK}	Host Mode Leakage current	Measured at V_{BUS_SYS} pin, V_{BUS_CON} = Hi-Z, $\overline{EN}$ = 5 V	V_{BUS_SYS} = 5 V	TPD1S514-1	90	218	µA
			V_{BUS_SYS} = 9 V	TPD1S514-2	290	491	
			V_{BUS_SYS} = 12 V	TPD1S514-3 (Preview)	506	696	
			V_{BUS_SYS} = 5 V	TPD1S514-4	90	218	

7.6 Electrical Characteristics $\overline{\text{EN}}$ Pin

over operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{IH}	High-level input voltage	$\overline{\text{EN}}$	V_{BUS_CON} = 5 V	1.2		6	V
V_{IL}	Low-level input voltage	$\overline{\text{EN}}$	V_{BUS_CON} = 5 V	0		0.8	V
I_{IL}	Input Leakage Current	$\overline{\text{EN}}$	$V_{\overline{\text{EN}}}$ = 0 V, V_{BUS_CON} = 5 V			1	µA
I_{IH}	Input Leakage Current	$\overline{\text{EN}}$	$V_{\overline{\text{EN}}}$ = 5 V, V_{BUS_CON} = 5 V			10	µA

7.7 Thermal Shutdown Feature

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
T_{SHDN}	Thermal Shutdown	V_{BUS_CON} = 5 V, $\overline{\text{EN}}$ = 0 V, Junction temperature decreases from thermal shutdown level until the nFET switch turns off.		145		°C
	Thermal Shutdown Hysteresis	V_{BUS_CON} = 5 V, $\overline{\text{EN}}$ = 0 V, Junction temperature decreases from thermal shutdown level until the nFET switch turns on.		25		°C

7.8 Electrical Characteristics nFET Switch

T = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
R_{ON}	Switch ON Resistance	V_{BUS_CON} = 5 V, I_{OUT} = 1 A	TPD1S514-1		39	50	mΩ
		V_{BUS_CON} = 9 V, I_{OUT} = 1 A	TPD1S514-2		39	50	
		V_{BUS_CON} = 12 V, I_{OUT} = 1 A	TPD1S514-3 (Preview)		39	50	
		V_{BUS_CON} = 5 V, I_{OUT} = 1 A	TPD1S514-4		39	50	

Product Folder Links: *TPD1S514*

7.9 Electrical Characteristics OVP Circuit

T = 25°C

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{OVP}	Input voltage protection threshold	V_{BUS_CON}	V_{BUS_CON} increasing from 0 V to 20 V	TPD1S514-1	5.90	5.95	5.99	V
				TPD1S514-2	9.9	9.98	10.05	
				TPD1S514-3 (Preview)	13.5	13.75	14	
				TPD1S514-4	5.90	5.95	5.99	
V_{HYS_OVP}	Hysteresis on OVP	V_{BUS_CON}	V_{BUS_CON} decreasing from 20 V to 0 V	TPD1S514-1		100		mV
				TPD1S514-2		100		
				TPD1S514-3 (Preview)		100		
				TPD1S514-4		20		
V_{UVLO}	Input under voltage lockout	V_{BUS_CON}	V_{BUS_CON} voltage rising from 0 V to 5 V		2.7	3.1	3.5	V
V_{HYS_UVLO}	Hysteresis on UVLO	V_{BUS_CON}	Difference between rising and falling UVLO thresholds			80		mV
$V_{UVLO\_FALLING}$	Input under voltage lockout	V_{BUS_CON}	V_{BUS_CON} voltage falling from 5 V to 0 V		2.6	3.0	3.4	V
V_{UVLO_SYS}	V_{BUS_SYS} under voltage lockout	V_{BUS_SYS}	V_{BUS_SYS} voltage rising from 0 V to 5 V		2.8	3.7	4.3	V
$V_{HYS\_UVLO\_SYS}$	V_{BUS_SYS} UVLO Hysteresis	V_{BUS_SYS}	Difference between rising and falling UVLO thresholds on V_{BUS_SYS}			500		mV
$V_{UVLO\_SYS\_FALLING}$	V_{BUS_SYS} under voltage lockout	V_{BUS_SYS}	V_{BUS_SYS} voltage falling from 5 V to 0 V		2.6	3.0	3.4	V

7.10 Electrical Characteristics V_{BUS_POWER} Circuit

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{CLAMP}	Output Voltage on V_{BUS_POWER} during OVP	V_{BUS_CON} = 20 V	TPD1S514-1		5.0	5.5	V
			TPD1S514-2		5.0	5.5	
			TPD1S514-3 (Preview)		5.0	5.5	
			TPD1S514-4		6.48	6.68	
V_{BUS_POWER}	Output Voltage on V_{BUS_POWER} during normal operation	V_{BUS_CON} = 5 V, I_{BUS_POWER} = 1 mA;	TPD1S514-1	4.7	4.95		V
			TPD1S514-2	4.7	4.95		
			TPD1S514-3 (Preview)	4.7	4.95		
			TPD1S514-4	4.7	4.98		
$I_{BUS\_POWER\_MAX}$	Output Current on V_{BUS_POWER}	V_{BUS_CON} = 5 V – 15 V				3	mA

Product Folder Links: TPD1S514

7.11 Timing Requirements

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{DELAY}	USB Charging Turn-ON Delay	Measured from $\overline{EN}$ asserted LOW to nFET begins to Turn ON, excludes soft-start time	TPD1S514-1		20		ms
			TPD1S514-2				
			TPD1S514-3 (Preview)				
			TPD1S514-4				
t_{SS}	USB Charging rise time (Soft Start Delay)	Measure from V_{BUS_SYS} rises above 25% (with 1 MΩ load/ NO C_{LOAD})	TPD1S514-1		3.5		ms
			TPD1S514-2				
			TPD1S514-3 (Preview)				
			TPD1S514-4				
t_{OFF_DELAY}	USB Charging Turn-OFF time	Measured from $\overline{EN}$ asserted High to V_{BUS_SYS} falling to 10% with $R_{LOAD} = 10Ω$ and No C_{LOAD} on V_{BUS_SYS}	TPD1S514-1		5.5		µs
			TPD1S514-2				
			TPD1S514-3 (Preview)				
			TPD1S514-4				
OVER VOLTAGE PROTECTION							
$t_{OVP\_response}$	OVP Response time	Measured from OVP Condition to FET Turn OFF[1]				100	ns

(1) Specified by design, not production tested
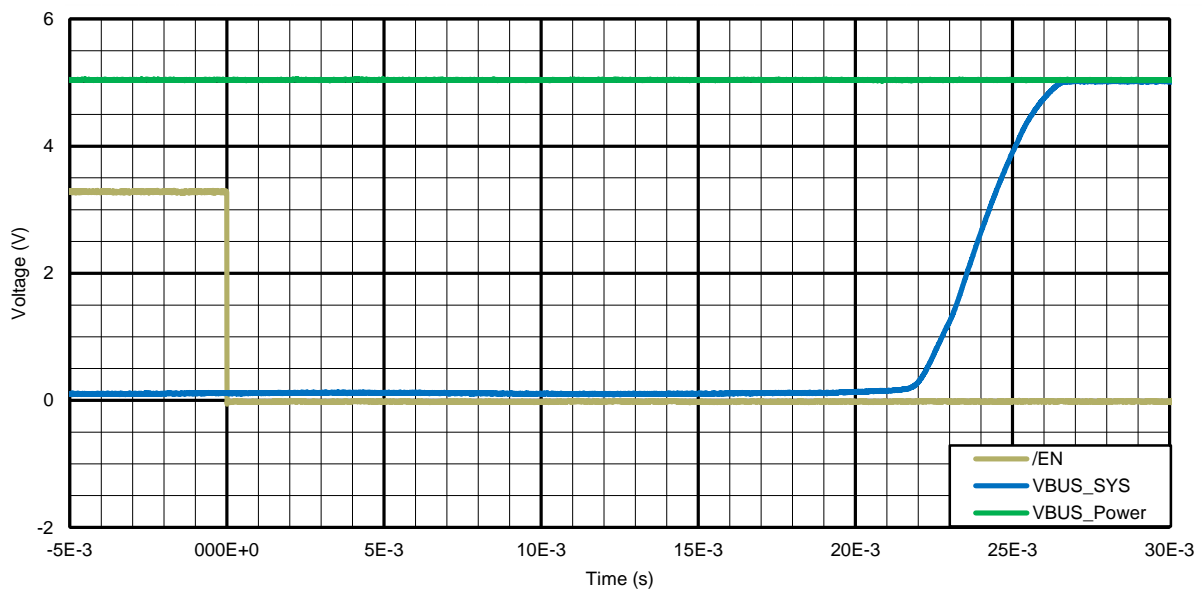
Figure 1. TPD1S514-1 Response to set $\overline{EN}$ low

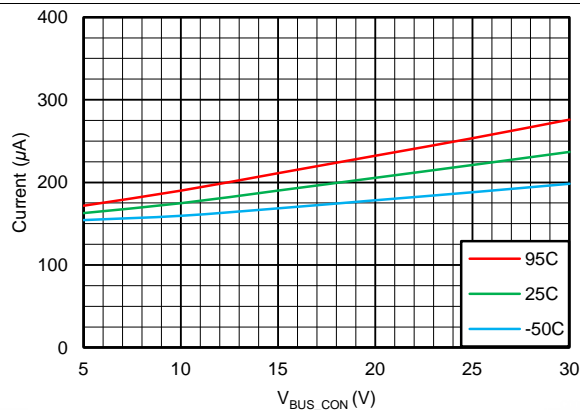## 7.12 TPD1S514-1 Typical Characteristics
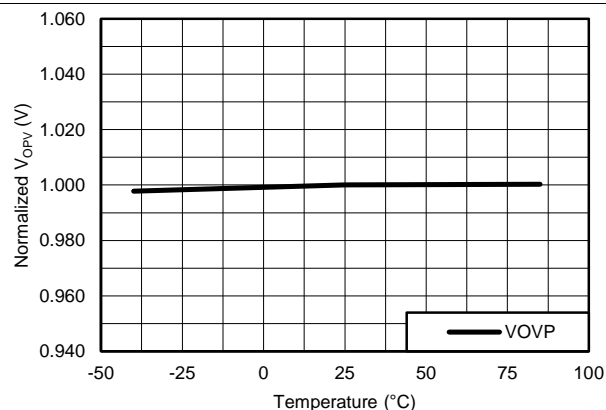

Figure 2. In Supply Current vs. Supply Voltage
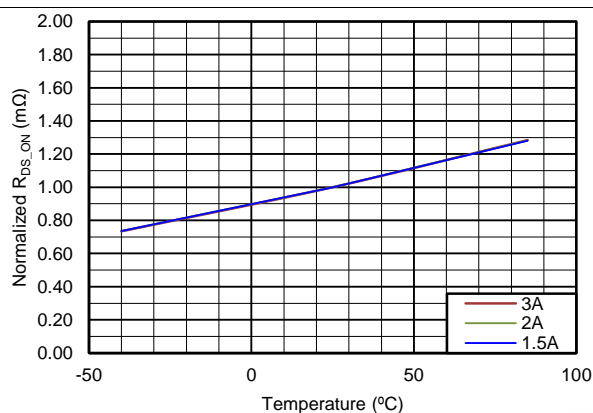

Figure 3. Normalized V_{OVP} vs. Temperature

Figure 4. Normalized R_{ON} vs. Temperature
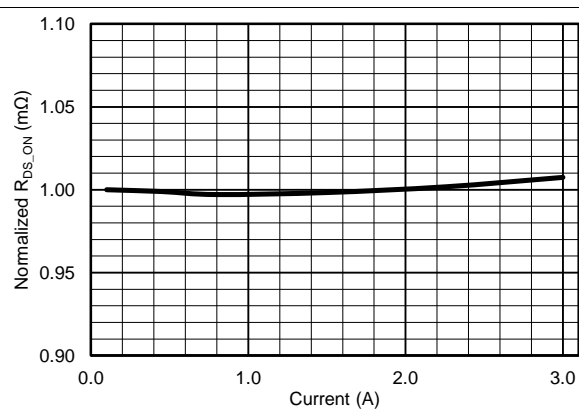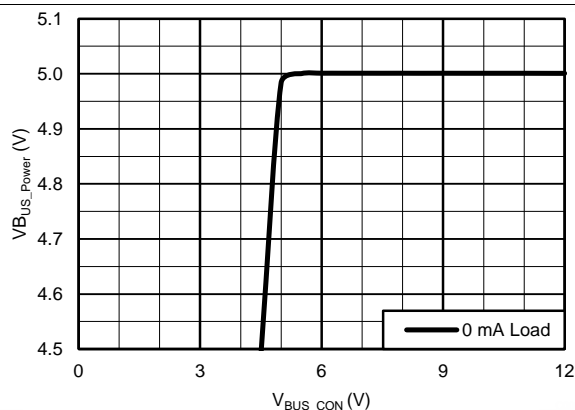

Figure 5. Normalized R_{ON} vs. Output

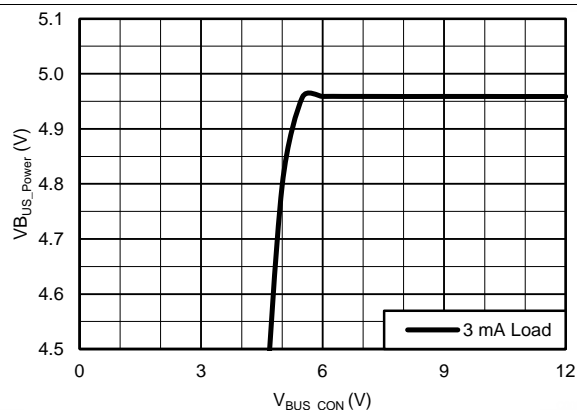Figure 6. V_{BUS_POWER} vs. V_{BUS_CON} With No Load

Figure 7. V_{BUS_POWER} vs. V_{BUS_CON} With 3 mA Load

TPD1S514-1 Typical Characteristics (continued)
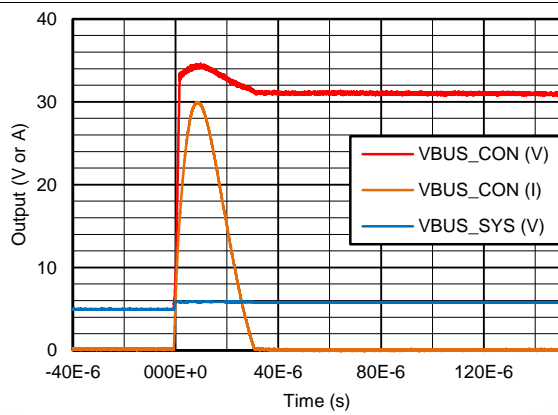
Figure 8. 100 V Surge With Device
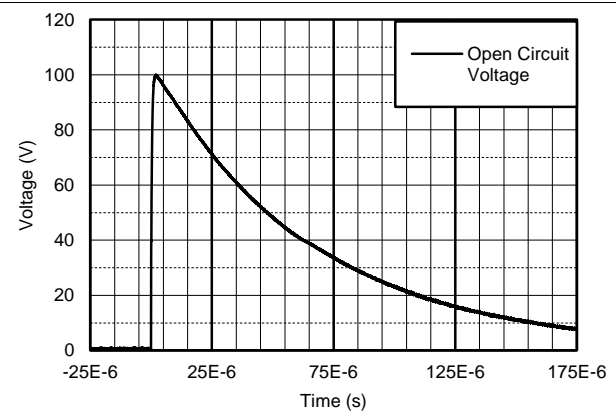

Figure 9. 100 V Surge Without Device

Product Folder Links: *TPD1S514*

8 Detailed Description

8.1 Overview

The TPD1S514 provides a single-chip ESD, surge, and over voltage protection solution for portable USB Charging and Host interfaces. It offers over voltage protection at the V_{BUS_CON} pin up to 30-V DC. The TPD1S514 offers an ESD and Precision Clamp for the V_{BUS_CON} pin, thus eliminating the need for external TVS clamp circuits in the application.

The TPD1S514 has an internal oscillator and charge pump which controls turning ON the internal nFET switch. The internal oscillator controls the timers which enable the charge pump. If V_{BUS_CON} is less than V_{OVP}, the internal charge pump is enabled. After a 20 ms internal delay, the charge-pump starts-up, and turns ON the internal nFET switch through a soft start. If at any time V_{BUS_CON} rises above V_{OVP}, the nFET switch is turned OFF within 100 ns.

The TPD1S514 also has a V_{BUS_POWER} pin which follows V_{BUS_CON} up to 4.9 V at 3 mA (except for TPD1S514, which follows V_{BUS_CON} up to 6.48 V, after which it is regulated to that voltage) to power the system from V_{BUS_CON}. In the case where the system battery state cannot power the system, voltage from an external charger can be provided to power the system. V_{BUS_POWER} is supplied by an always on LDO regulator supplied by V_{BUS_CON}. V_{BUS_POWER} output voltage remains regulated to 4.9 V (except for TPD1S514, which follows V_{BUS_CON} up to 6.48 V, after which it is regulated to that voltage) at up to 30-V DC on V_{BUS_CON} and during IEC61000-4-5 surge events of up to 100 V open circuit voltage on V_{BUS_CON}.

8.2 Functional Block Diagram
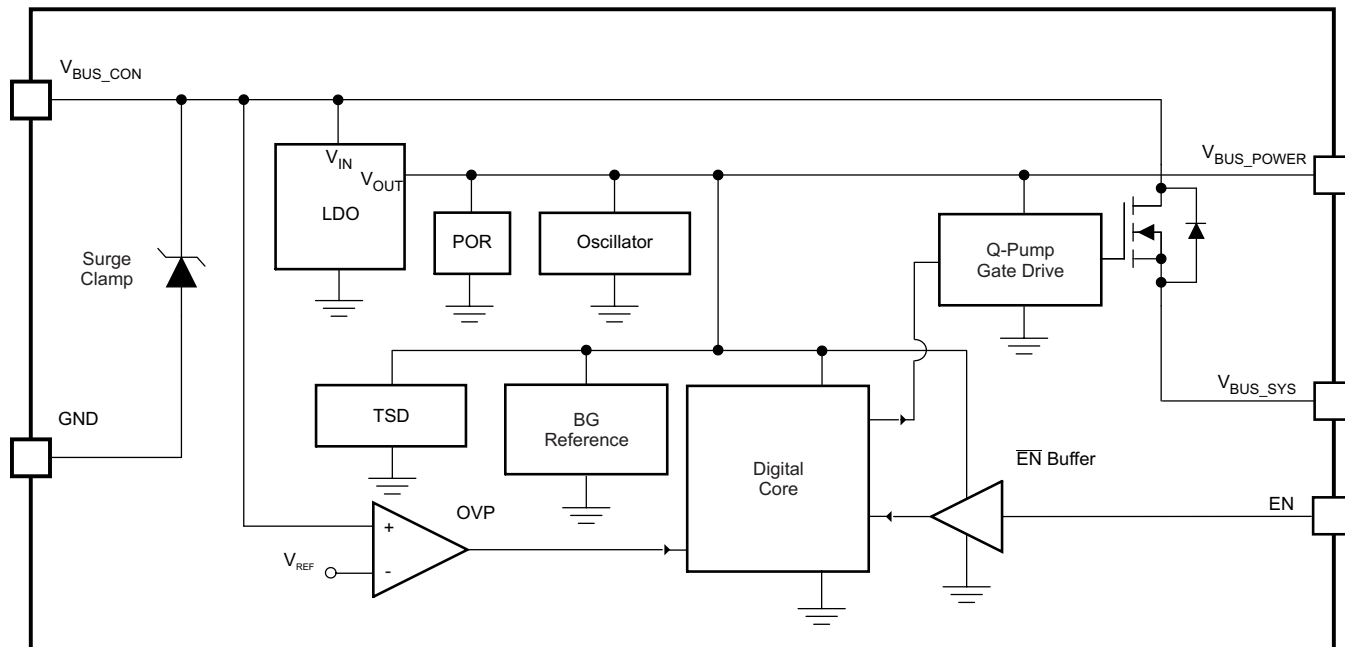
8.3 Feature Description

8.3.1 Over Voltage Protection on V_{BUS_CON} up to 30 V DC

When the V_{BUS_CON} voltage rises above V_{OVP}, the internal nFET switch is turned OFF, removing power from the system side. V_{BUS_CON} can tolerate up to 30-V DC. The response to over voltage is very rapid, with the nFET switch turning off in less than 100 ns. When the V_{BUS_CON} voltage returns back to below $V_{OVP} - V_{HYS\_OVP}$, the nFET switch is turned ON again after an internal delay of t_{OVP_RECOV} (t_{DELAY}). This time delay ensures that the V_{BUS_CON} supply has stabilized before turning the switch back on. After t_{OVP_RECOV}, the TPD1S514 turns on the nFET through a soft start. Once the OVP condition is cleared the nFET is turned completely ON.

Feature Description (continued)

8.3.2 Precision OVP (< ±1% Tolerance)

1% OVP trip threshold accuracy allows use of the entire input charging range while protecting sensitive system-side components from overvoltage conditions.

8.3.3 Manufacturer Programmable Internal Startup, SoftStart Delays, and OVP

TPD1S514 with V_{BUS_POWER} = 4.95 V can be manufactured pre-programmed with the startup time, t_{DELAY}, ranging from 5 ms to 150 ms. Also, the SoftStart, t_{SS}, can be manufactured pre-programmed with a range of 0.1 ms to 6.7 ms. Also, OVP can be manufactured to protect at levels of 5.6 V – 15 V in 30 mV steps. Any of these three parameters can be configured independent of the others. In all cases V_{BUS_POWER} = 4.95 V.

   a. Factory programmable parameters:
      i. t_{DELAY}: 5 ms, 20 ms, 30ms, or 150 ms
      ii. t_{SS}: 0.1 ms, 3.5 ms, 4.9 ms, or 6.7 ms
      iii. OVP: 5.6 V – 15 V in 30 mV steps

8.3.4 Low R_{ON} nFET Switch Supports Host and Charging Mode

The nFET switch has a total on resistance (R_{ON}) of 39 mΩ. This equates to a voltage drop of less than 140 mV when charging at the maximum 3.5 A current level. Such low RON helps provide maximum potential to the system as provided by an external charger or by the system when in Host Mode.

8.3.5 V_{BUS_POWER}, TPD1S514-1, TPD1S514-2, TPD1S514-3

The V_{BUS_POWER} pin provides up to 3 mA and 5 V for powering the system using V_{BUS_CON}. V_{BUS_POWER} follows V_{BUS_CON} after 3.5 V and up to the regulated 5 V. In the case where the system battery state cannot power the system, voltage from an external charger can power the system. V_{BUS_POWER} is supplied by an always on LDO regulator supplied by V_{BUS_CON}. The V_{BUS_POWER} output voltage remains regulated to 5 V at up to 30-V DC on V_{BUS_CON} and during IEC61000-4-5 surge events of up to 100 V.

8.3.6 V_{BUS_POWER}, TPD1S514

The V_{BUS_POWER} pin provides up to 3 mA and 6.48 V for powering the system using V_{BUS_CON}. V_{BUS_POWER} follows V_{BUS_CON} after 3.5 V and up to the regulated 6.48 V. In the case where the system battery state cannot power the system, voltage from an external charger can be provided to power the system. V_{BUS_POWER} is supplied by an always on LDO regulator supplied by V_{BUS_CON}. The V_{BUS_POWER} output voltage remains regulated to 6.48 V at up to 30-V DC on V_{BUS_CON} and during IEC61000-4-5 surge events of up to 100 V.

8.3.7 Powering the System When Battery is Discharged

There are two methods for powering the system under a dead battery condition. Case 1: The $\overline{EN}$ pin can be tied to ground so that the nFET is always ON (when $V_{UVLO} < V_{BUS\_CON} < V_{OVP}$) and an external charger can power VBUS. Case 2: If $\overline{EN}$ is controlled by a Power Management Unit (PMIC) or other logic, V_{BUS_POWER} can be used to power the PMIC.

8.3.8 ±15 kV IEC61000-4-2 Level 4 ESD Protection

The V_{BUS_CON} pin can withstand ESD events up to ±15 kV Contact and Air-Gap. An ESD clamp diverts the current to ground.

8.3.9 100 V IEC61000-4-5 µs Surge Protection

The V_{BUS_CON} pin can withstand surge events up to 100 V open circuit voltage (V_{PP}), or 900 W. A Precision Clamp diverts the current to ground and active circuitry switches OFF the nFET earlier than 100 ns before an overvoltage can get through to V_{BYS_SYS}. The ultra-fast response time of TPD1S514 holds the voltage on V_{BUS_SYS} to less than V_{OVP} during surge events of up to 100 V_{PP}.

Feature Description (continued)

8.3.10 Startup and OVP Recovery Delay

Upon startup or recovering from an over voltage, TPD1S514 has a built in startup delay. An internal oscillator controls a charge pump to control the delay. Once a manufactured pre-programmed time, t_{DELAY}, has elapsed, the charge pump is enabled which turns ON the nFET. A manufactured pre-programmed soft start, t_{SS}, is used when turning ON the nFET. These start delays, $t_{DELAY} + t_{SS}$, work together to meet USB Inrush Current compliance.

8.3.11 Thermal Shutdown

TPD1S514 has an over-temperature protection circuit to protect against system faults or improper use. The basic function of the thermal shutdown (TSD) circuit is to sense when the junction temperature has exceeded the absolute maximum rating and shuts down the device until the junction temperature has cooled to a safe level.

8.4 Device Functional Modes

8.4.1 Operation With V_{BUS_CON} < 3.5 V (Minimum V_{BUS_CON})

TPD1S514 operates normally (nFET ON) with input voltages above 3.5 V. The maximum UVLO voltage is 3.5 V and the device will operate at input voltages above 3.5 V. The typical UVLO voltage is 3.1 V and the device may operate at input voltages above that point. The device may also operate at input voltages as low as 2.7 V, the minimum UVLO. At input voltages between 0.6 V and 1.2 V, the state of output pins may not be controlled internally.

8.4.2 Operation With V_{BUS_CON} > V_{OVP}

TPD1S514 operates normally (nFET ON) with input voltages below V_{OVP_min}. The typical OVP voltage is V_{OVP_TYP} and the device may operate at input voltages below that point. The device may also operate at input voltages as high as V_{OVP_MAX}.

Device Name	V_{OVP}		
	MIN	**TYP**	**MAX**
TPD1S514-1	5.9	5.95	5.99
TPD1S514-2	9.9	9.98	10.05
TPD1S514-3 (Preview)	13.2	13.32	13.4
TPD1S514-4	5.9	5.95	5.99

8.4.3 OTG Mode

The TPD1S514 UVLO and OVP voltages are referenced to V_{BUS_CON} voltage. In OTG mode, V_{BUS_SYS} is driving the V_{BUS_CON}. Under this situation, initially V_{BUS_CON} is powered through the body diode of the nFET by V_{BUS_SYS}. Once the UVLO threshold on V_{BUS_CON} is met, the nFET turns ON. If there is a short to ground on V_{BUS_CON} the OTG supply is expected to limit the current.

9 Application and Implementation

9.1 Application Information

The devices offer V_{BUS} port protection implementing UVLO and OVP, with an LDO supplied V_{BUS_POWER} pin to regulate an output supply pin of 3 mA at 5 V (except for TPD1S514, which follows V_{BUS_CON} up to 6.48 V, after which it is regulated to that voltage). The V_{BUS_POWER} pin can be used to power the system from an external source on V_{BUS_CON} in case the system's battery state cannot power the system.

9.2 Typical Application

9.2.1 TPD1S514-1 USB 2.0/3.0 Case 1: Always Enabled

The $\overline{EN}$ pin can be tied to ground so that the nFET is ON when $V_{UVLO} < V_{BUS\_CON} < V_{OVP}$ and an external charger can power V_{BUS}. V_{BUS_POWER} can be left floating.
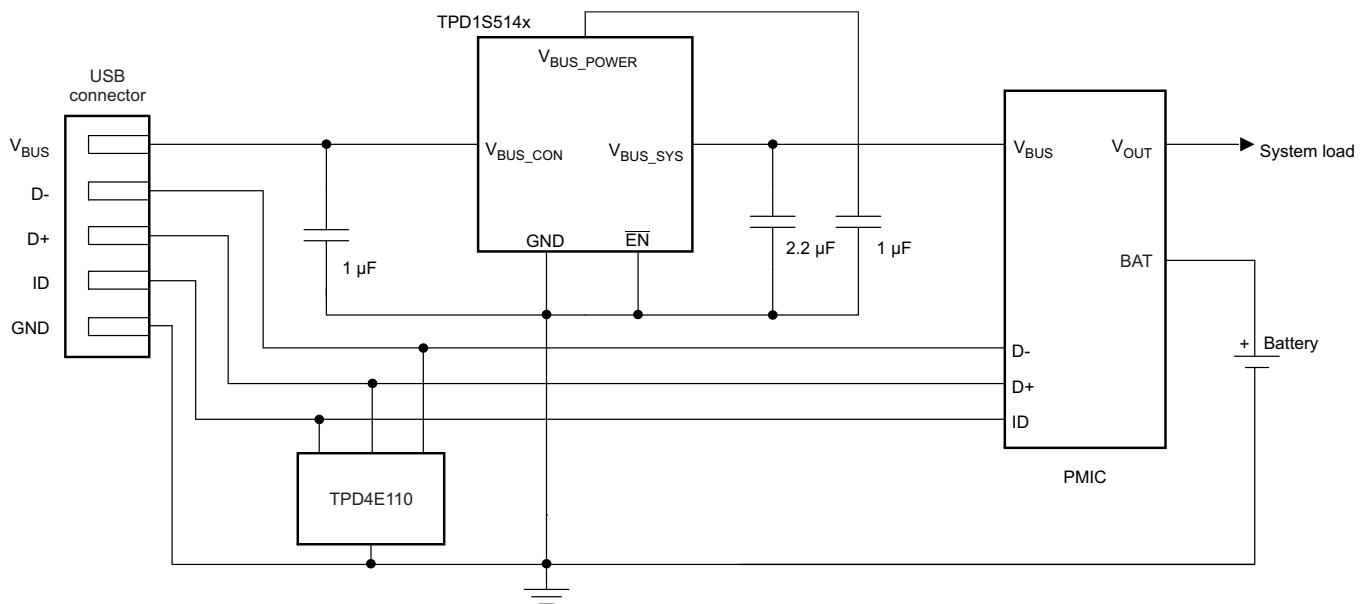

Figure 10. Always on, TPD1S514-1

9.2.1.1 Design Requirements

For this example, use the following table as input parameters:

Design Parameters	Example Value
Signal range on V_{BUS_CON}	3.5 V – 5.9 V
Signal range on V_{BUS_SYS}	3.9 V – 5.9 V
Signal on $\overline{EN}$	Tie to system ground plane

9.2.1.2 Detailed Design Procedure

To begin the design process the designer needs to know the V_{BUS} voltage range.

9.2.1.2.1 V_{BUS} Voltage Range

The UVLO trip-point is a maximum 3.5 V and the OVP trip-point is a minimum 5.9 V. This provides some headroom for the USB 2.0 specified minimum 4.4 V (Low-power) or 4.75 V (Full-power) and 5.25 V maximum; or the USB 3.0 specified minimum 4.45 V and 5.25 V maximum.

9.2.1.2.2 Discharged Battery

Connecting $\overline{EN}$ to ground sets the part active at all times. OVP and UVLO are always active, even when the system battery is fully discharged. In the case of a discharged system battery, V_{BUS_SYS} can be used to power the system when a source with voltage between V_{UVLO} and V_{OVP} is attached to V_{BUS_CON}.
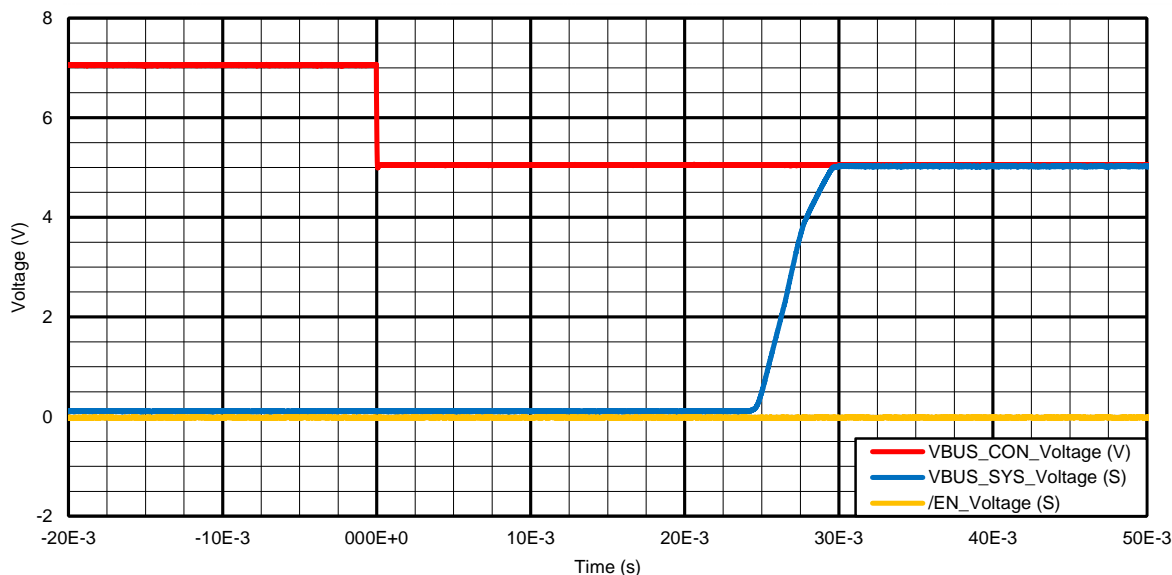
9.2.1.3 Application Curves

Figure 11. V_{BUS_SYS} Recovery Time From Over-Voltage on V_{BUS_CON}

9.2.2 TPD1S514-1 USB 2.0/3.0 Case 2: PMIC Controlled $\overline{EN}$

TPD1S514 offers more flexibility to system designers to power up the system during a dead battery condition. Refer to Figure 12, the V_{BUS_POWER} pin supplies 4.95 V and 3 mA to power the PMIC in a dead battery condition. Regardless of $\overline{EN}$ state, V_{BUS_POWER} is available to the PMIC. Utilizing this power, the PMIC can enable TPD1S514 when the valid V_{BUS_CON} voltage is present.
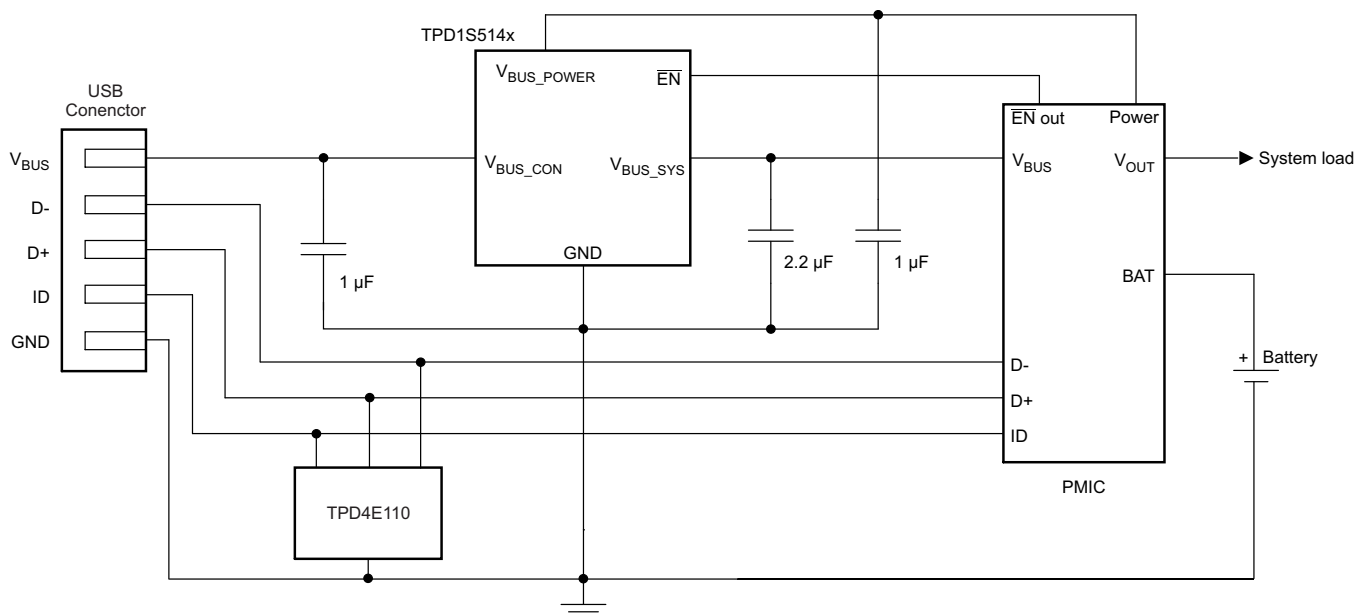

Figure 12. PMIC Controlled $\overline{EN}$, TPD1S514-1

9.2.2.1 Design Requirements

For this example, use the following table as input parameters:

Design Parameters	Example Value
Signal range on V_{BUS_CON}	3.5 V – 5.9 V
Signal range on V_{BUS_SYS}	3.9 V – 5.9 V
Drive $\overline{EN}$ low (enabled)	0 V – 0.8 V
Drive $\overline{EN}$ high (disabled)	1.2 V – 6.0 V

9.2.2.2 Detailed Design Procedure

To begin the design process, some parameters must be decided upon. The designer needs to know the following:

- V_{BUS} voltage range
- PMIC power requirement

9.2.2.2.1 V_{BUS} Voltage Range

The UVLO trip-point is a maximum 3.5 V and the OVP trip-point is a minimum 5.9 V. This provides some headroom for the USB 2.0 specified minimum 4.4 V (Low-power) or 4.75 V (Full-power) and 5.25 V maximum; or the USB 3.0 specified minimum 4.45 V and 5.25 V maximum.

9.2.2.2.2 PMIC Power Requirement

The V_{BUS_POWER} pin can source up to 3 mA of current and maintain a minimum 4.8 V, 4.95 V typical. TPD1S514-1 design provides an LDO regulator supplied voltage source which can be used to provide power to a PMIC when its internal battery supplied power is unavailable. When selecting a matching PMIC, ensure its power requirement can be met by the V_{BUS_POWER} pin if designing for this scenario.

Product Folder Links: *TPD1S514*

9.2.2.2.3 Discharged Battery

Powering the PMIC from V_{BUS_POWER} allows logic control of the $\overline{EN}$ pin to set TPD1S514-1 active and begin charging the battery and powering up the rest of the system.

9.2.2.3 Application Curves
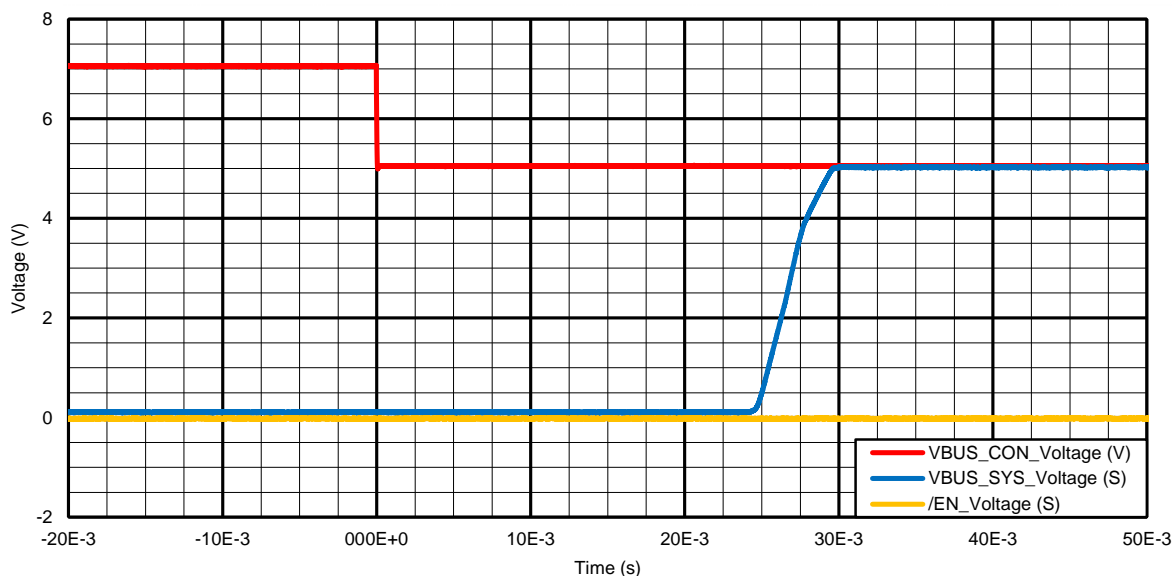
Figure 13. V_{BUS_SYS} Recovery Time From Over-Voltage on V_{BUS_CON}

10 Power Supply Recommendations

TPD1S514 Is designed to receive power from a USB 3.0 (or lower) V_{BUS} source. It can operate normally (nFET ON) between a minimum 3.5 V and a maximum V_{OVP_MIN} V. Thus, the power supply (with a ripple of V_{RIPPLE}) requirement for TPD1S514 to be able to switch the nFET ON is between 3.5 V + V_{RIPPLE} and $V_{OVP\_MIN} - V_{RIPPLE}$, where V_{OVP_MIN} is:

Device Name	V_{OVP_MIN}
TPD1S514-1	5.90 V
TPD1S514-2	9.9 V
TPD1S514-3 (Preview)	13.2 V
TPD1S514-4	5.90 V

Product Folder Links: *TPD1S514*

11 Layout

11.1 Layout Guidelines

- The optimum placement is as close to the connector as possible.
    - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
   - The PCB designer needs to minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
    - Electric fields tend to build up on corners, increasing EMI coupling.

11.2 Layout Example
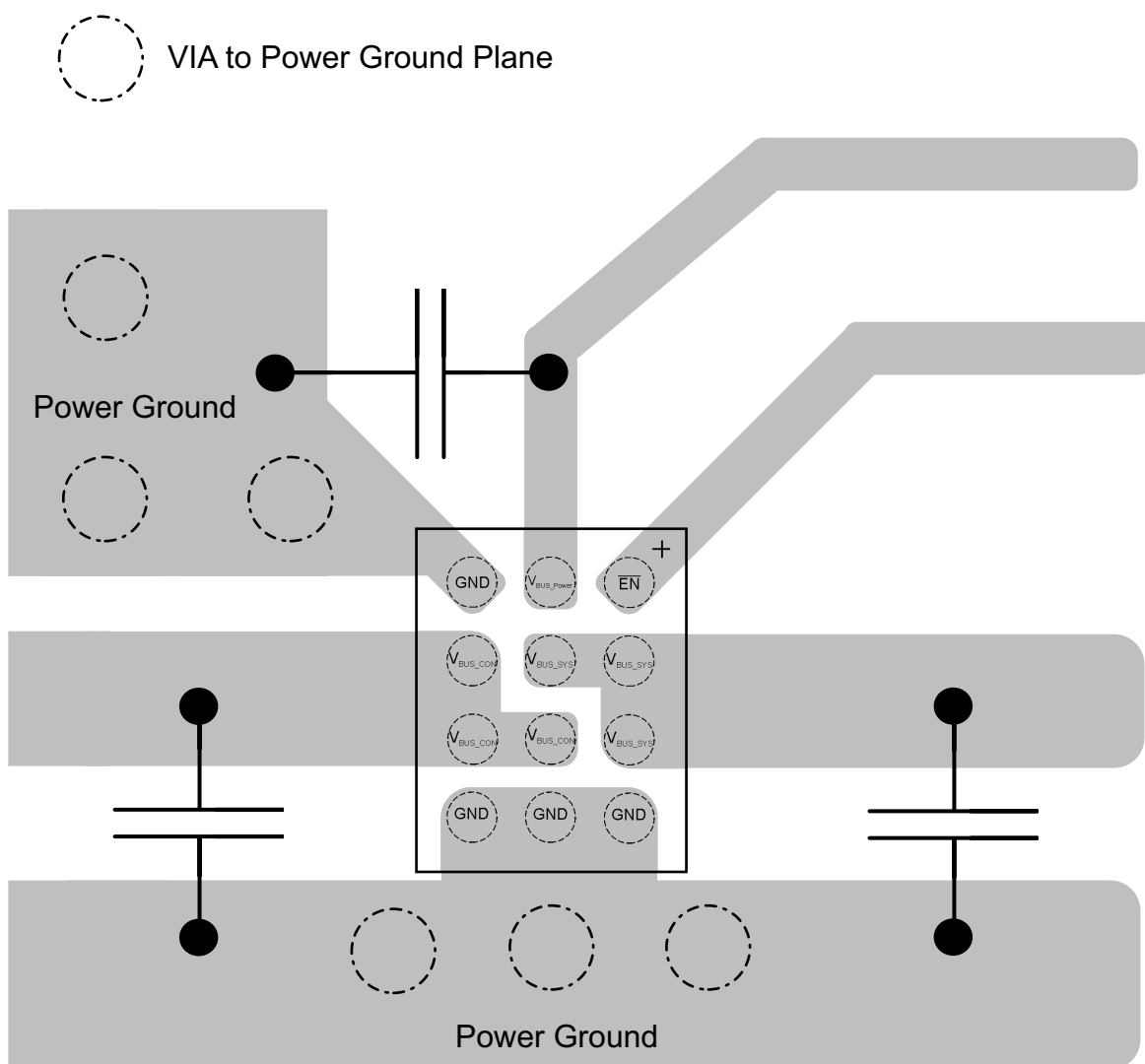
When designing layout for TPD1S514, note that V_{BUS_CON} and V_{BUS_SYS} pins allow extra wide traces for good power delivery. In the example shown, these pins are routed with 50 mil (1.27 mm) wide traces. Place the V_{BUS_CON}, V_{BUS_SYS}, and V_{BUS_POWER} capacitors as close to the pins as possible. Use external and internal ground planes and stitch them together with VIAs as close to the GND pins of TPD1S514 as possible. This allows for a low impedance path to ground so that the device can properly dissipate any surge or ESD events.

12 Device and Documentation Support

12.1 Trademarks

All trademarks are the property of their respective owners.

12.2 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.3 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

1,32
1,26

B

A

2,02
1,96

Ball A1 Index Area

0,80

0,40

4

3

2

1

C   B   A

Bottom View

0,20

1,20

0,40

12X ∅ 0,30
         0,20

⊕ ∅ 0,015 Ⓜ C A B

0,625 Max

0,05 C

Seating Plane

C

0,30
0,12
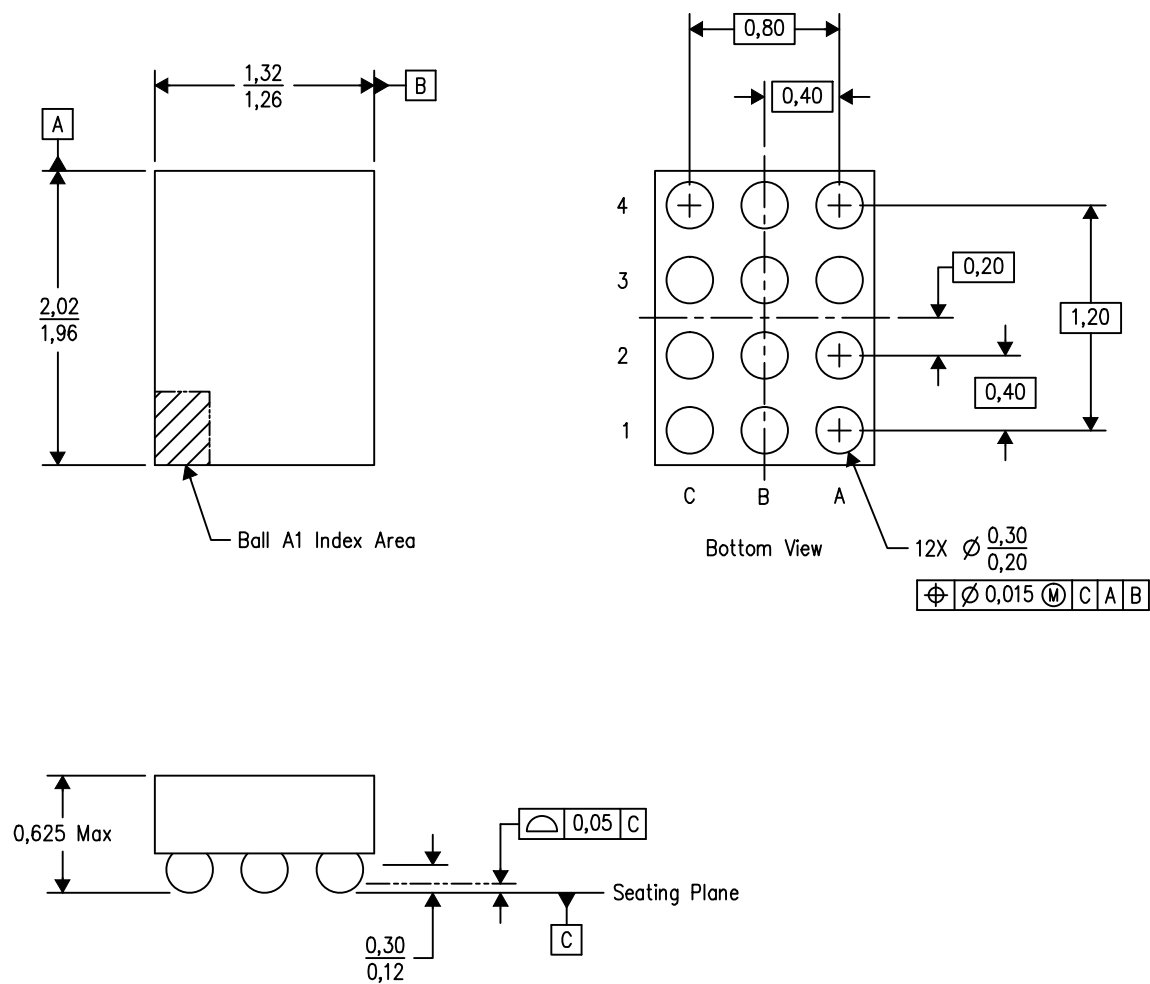
TPD1S514/BS   12/13

NOTES: A.   All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M−1994.
         B.   This drawing is subject to change without notice.
         C.   NanoFree™ package configuration.

NanoFree is a trademark of Texas Instruments.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPD1S514-1YZR	ACTIVE	DSBGA	YZ	12	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	RH5141	Samples
TPD1S514-2YZR	ACTIVE	DSBGA	YZ	12	3000	Green (RoHS & no Sb/Br)	Call TI | SNAGCU	Level-1-260C-UNLIM	-40 to 85	RH5142	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
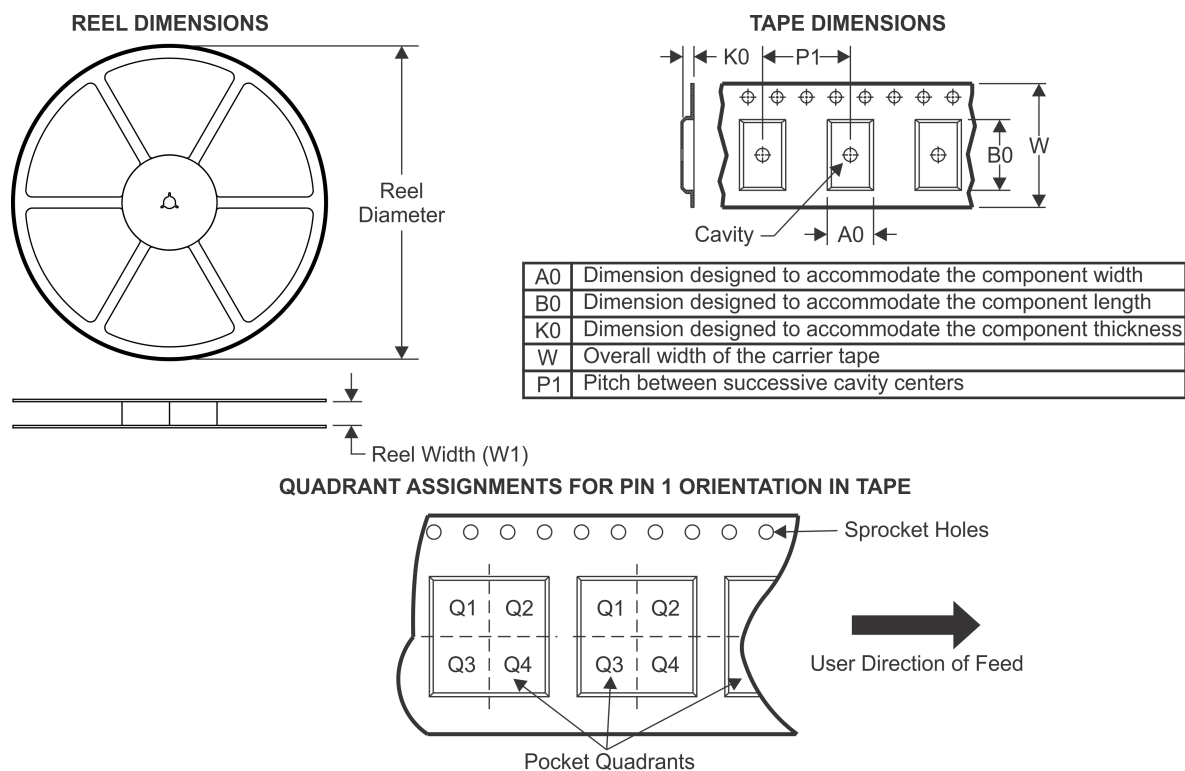
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPD1S514-1YZR	DSBGA	YZ	12	3000	180.0	8.4	1.39	2.09	0.75	4.0	8.0	Q2
TPD1S514-2YZR	DSBGA	YZ	12	3000	180.0	8.4	1.39	2.09	0.75	4.0	8.0	Q2
TPD1S514-2YZR	DSBGA	YZ	12	3000	178.0	9.2	1.42	2.1	0.76	4.0	8.0	Q2

![Texas Instruments logo] **PACKAGE MATERIALS INFORMATION**

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPD1S514-1YZR	DSBGA	YZ	12	3000	182.0	182.0	17.0
TPD1S514-2YZR	DSBGA	YZ	12	3000	182.0	182.0	17.0
TPD1S514-2YZR	DSBGA	YZ	12	3000	220.0	220.0	35.0

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